



Vehicle Safety, beyond ISO and ASIL: How Ethernet networking components will enhance the safety of self-driving cars

- **Steffen Lorenz**, Principal Application Architect - NXP Automotive Ethernet Solutions
- **Claude R. Gauthier**, Director of Strategic Innovation - NXP Automotive Ethernet Solutions
- **Jochen Schyma**, Product Manager - NXP Automotive Ethernet Solutions

AGENDA

- Trends in EE architectures
- Functional safety today
- Functional safety in the robot-car era

Trends in EE Architectures



SECURE CONNECTIONS
FOR A SMARTER WORLD

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Automotive Mega-Trends



Autonomous
Accident Free



Safe Transport
Optimized Routing
Driving Comfort



Electrification
Oil-Independent



Zero Emission



Service Oriented
User Defined



Entertainment
Security
Customization

MEGA TRENDS FORCE VEHICLE ARCHITECTURE TRANSFORMATION

TODAY:
FLAT

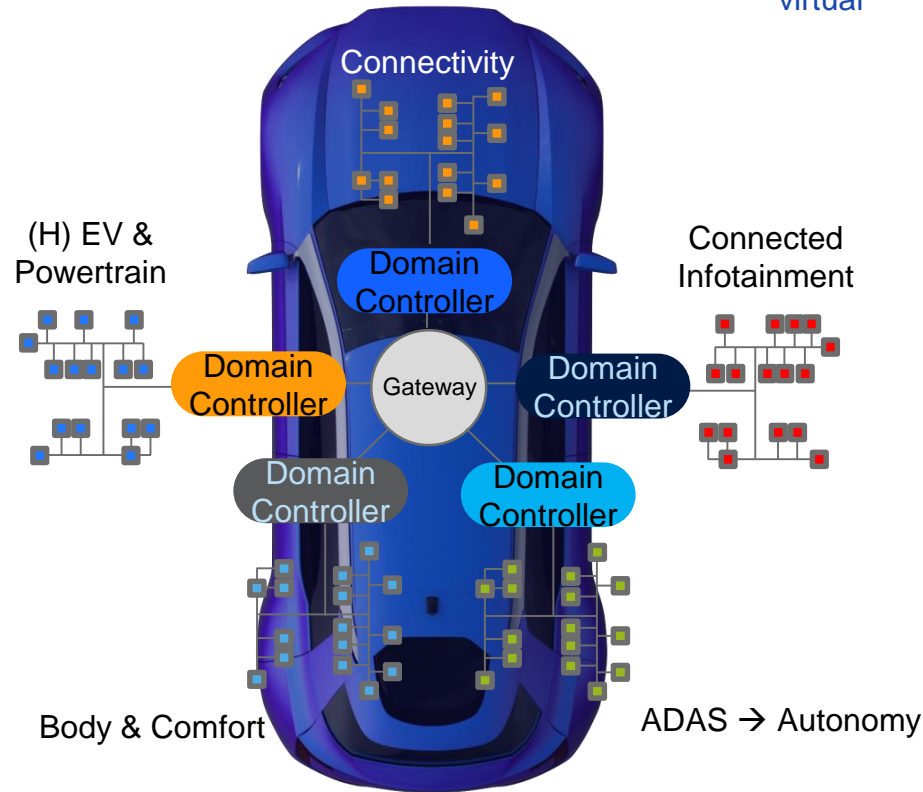


Low bandwidth, flat network
One MCU per application

UNFIT FOR FUTURE
MOBILITY

➔
Flat to
hierarchical

TOMORROW:
DOMAINS

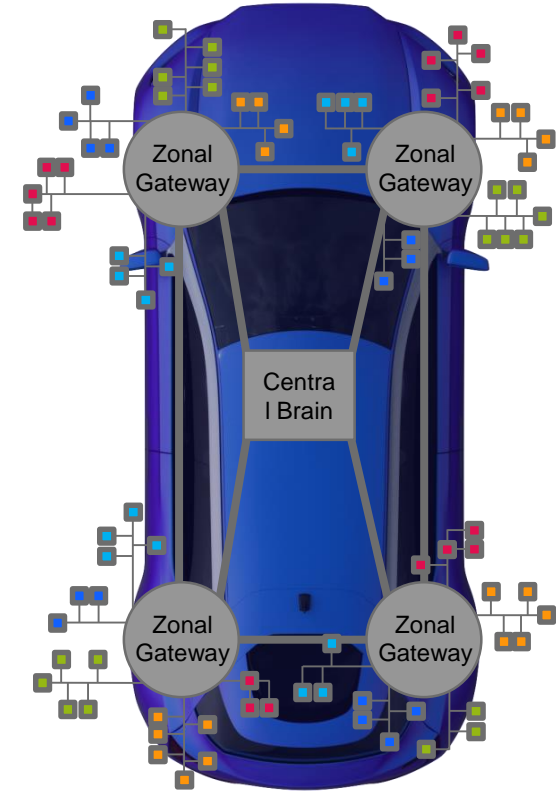


High bandwidth network
Gateway key to communication between domains

STEP TO
AUTONOMOUS CAR

➔
Wires go
virtual

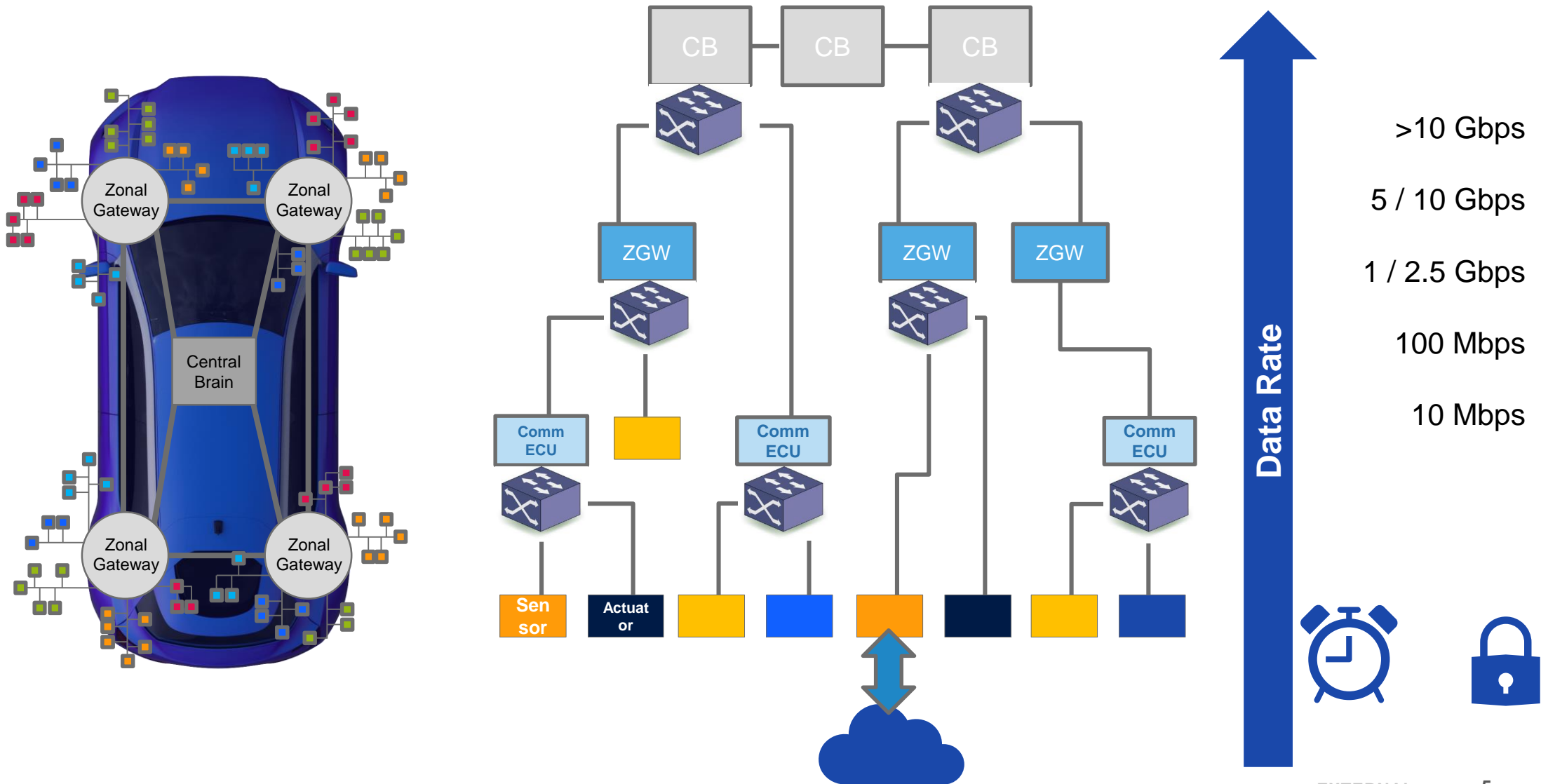
AFTER TOMORROW:
ZONES



Domains virtualized by SW – enabling high flexibility
Easy enable/disable or update functions

STEP TO USER-
DEFINED CAR

...TREND TO FULLY HIERARCHICAL ETHERNET NETWORK



ISO 26262 – The Science of Quantifying Risk

Severity



How much harm is done?

Exposure

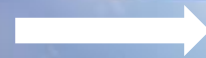


How often is it likely to happen?

Controllability



Can the hazard be controlled?



ASIL
Automotive Safety Integrity level

Inherent Risk

ISO 26262, part 1:
“*absence of unreasonable risk due to hazards caused by malfunctioning behaviour of E/E systems*”

Reduce risk
to an
acceptable
level



QM

ASIL A

ASIL B

ASIL C

ASIL D

Functional Safety Today



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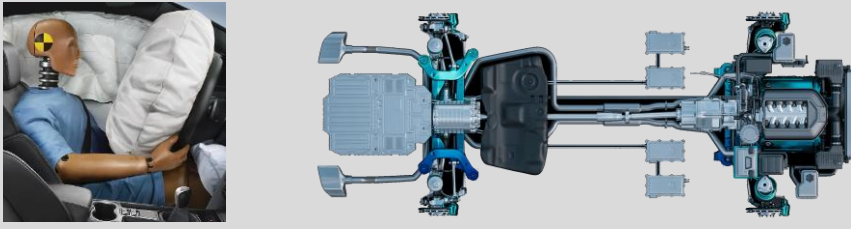
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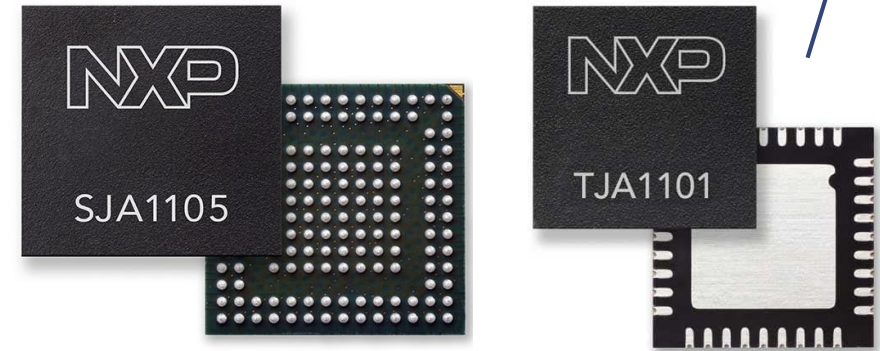
MAPPING OF FUNCTIONAL SAFETY REQUIREMENTS TO SEMICONDUCTORS

Contains functions with certain safety requirements (specific “context”):



Derived Functional Safety requirement: ???

In-Vehicle Networking products enable many different functions. Detailed information of the system requirements of the actual use cases are usually not available



System definition



System safety concept



System safety analysis

OEM A, B, C...



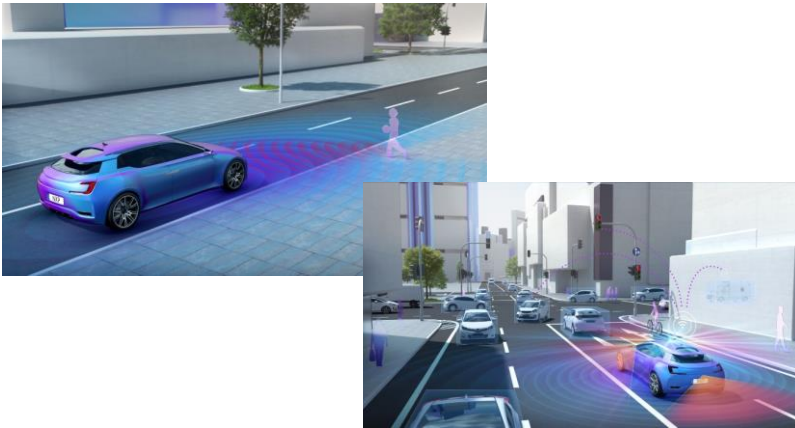
Map to semiconductor product safety concept (hardware, software)

Semiconductor Manufacturer A, B, C...

DEFINING SEMICONDUCTOR PRODUCTS AS “SAFETY ELEMENT OUT OF CONTEXT”



- **Assume** the use cases in the car (context)
- **Assume** safety goals



- Assume the context, derive commonalities with relevance for In-Vehicle Networking
- E.g. ADAS, like adaptive cruise control or parking assistant with multiple sensors, like radar and camera.

Assume the acceptable risk level per function

→ Define goal: ASIL A/B/C/D



Transfer the assumed system requirement into product requirements and identify the related functional blocks.

e.g. Which level of self diagnosis is required during operation and which part of the product is involved in diagnostics

INTEGRATION FLOW – FROM CHIP TO SYSTEM

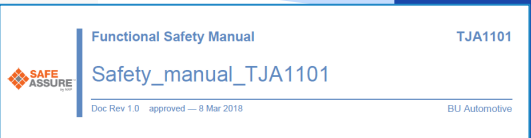
NXP adds safety features based on assumptions

Customer to match assumptions to real use case

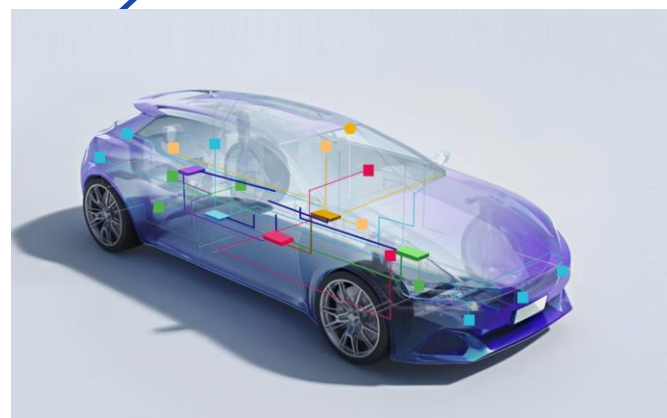
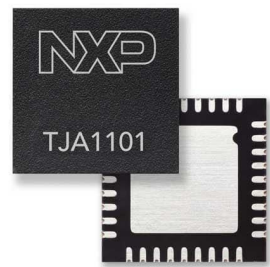
Matched! chip ASIL rating is valid when the assumptions are valid

SEooC
Safety Element out of Context

Chip development follows
ISO 26262 recommendations



**System
integration**



FUNCTIONAL SAFETY COMMITMENT SAFEASSURE



The **SafeAssure** program → NXP's commitment to supporting functional safety through a safety-conscious culture, discipline and collaboration

- **Hardware**

- Detect and mitigate random hardware failures using built-in safety features
- Automotive Ethernet, MCUs, analog and power management ICs and sensors

- **Software**

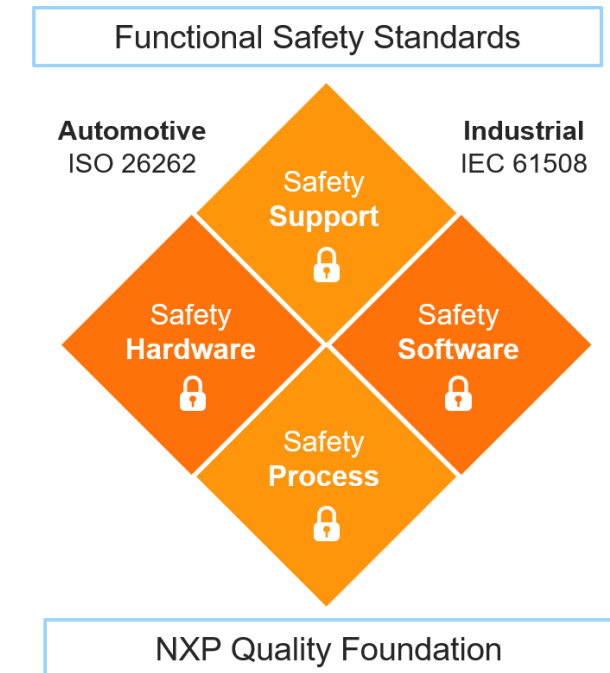
- Works seamlessly with hardware for system-level functional safety goals

- **Support**

- Safety documents, Technical support
- SafeAssure product-specific safety documents, upon request

- **Process**

- ISO 26262 certified hardware development process
- Preventing systematic failures



Design for Functional Safety goes far beyond the single product...

It requires a living culture and development process to enable the system advantage.

Functional Safety in The Robot-Car Era



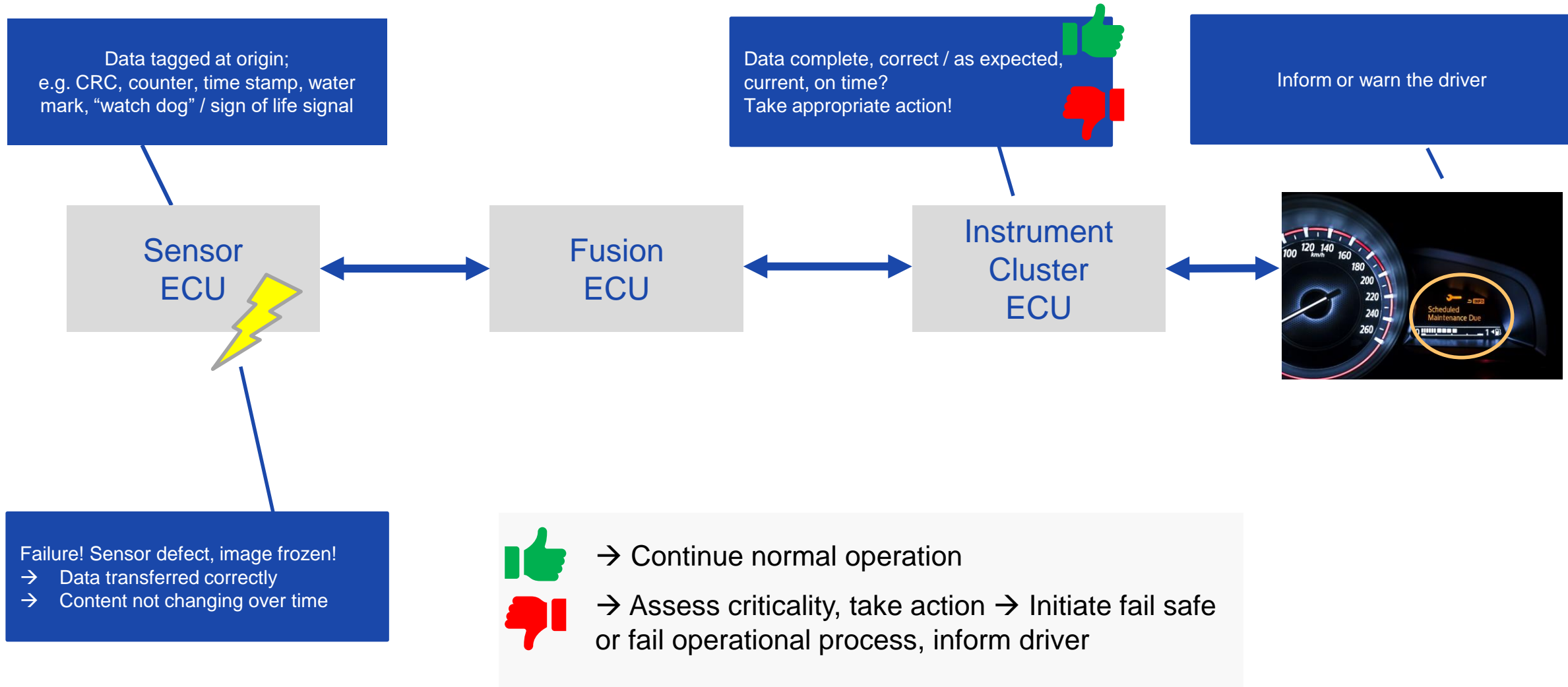
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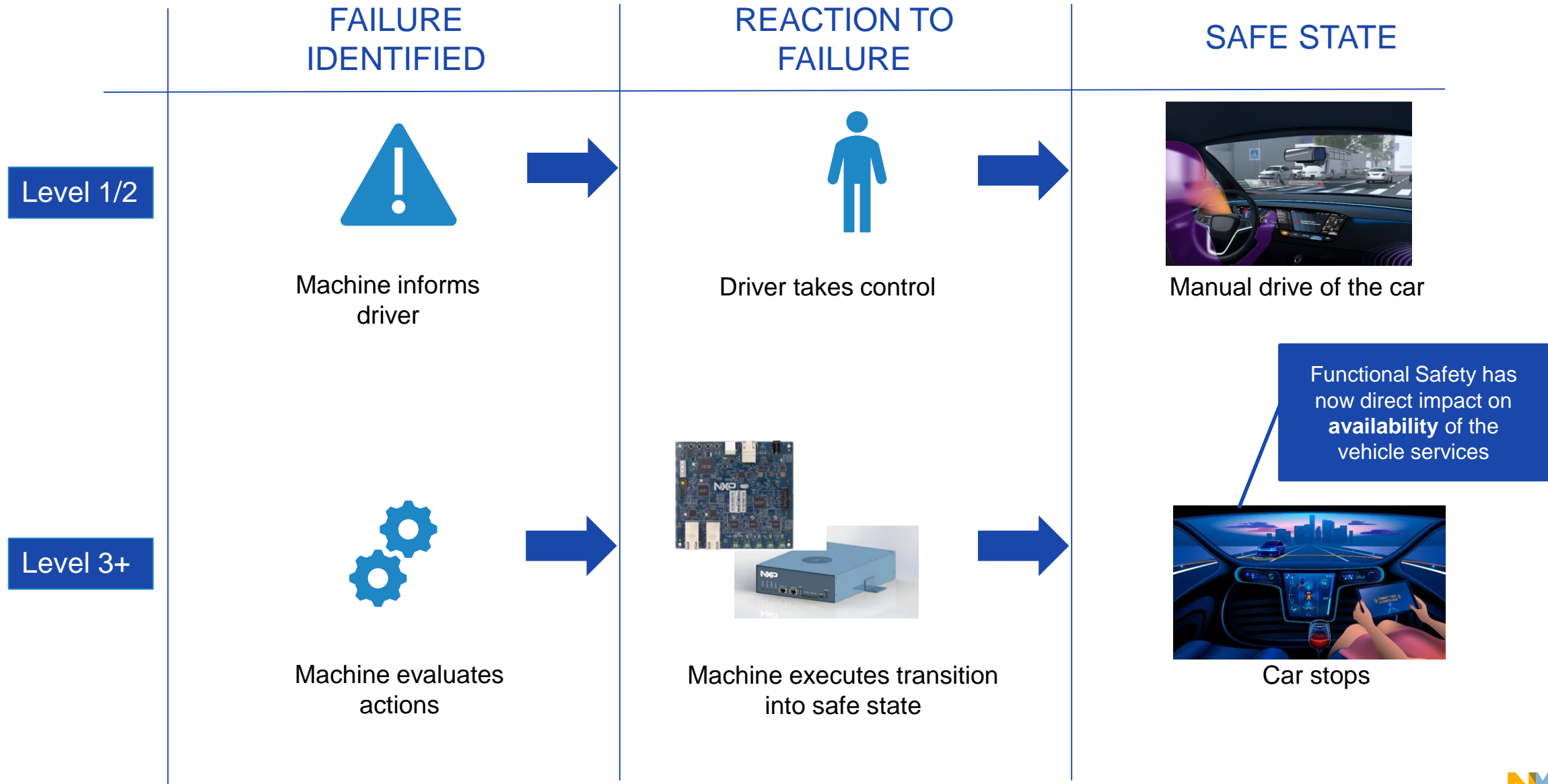
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END-TO-END FUSA IMPLEMENTATION EXAMPLE UP TO AD LEVEL 2



HOW IS AUTONOMOUS DRIVING CHANGING THE GAME?



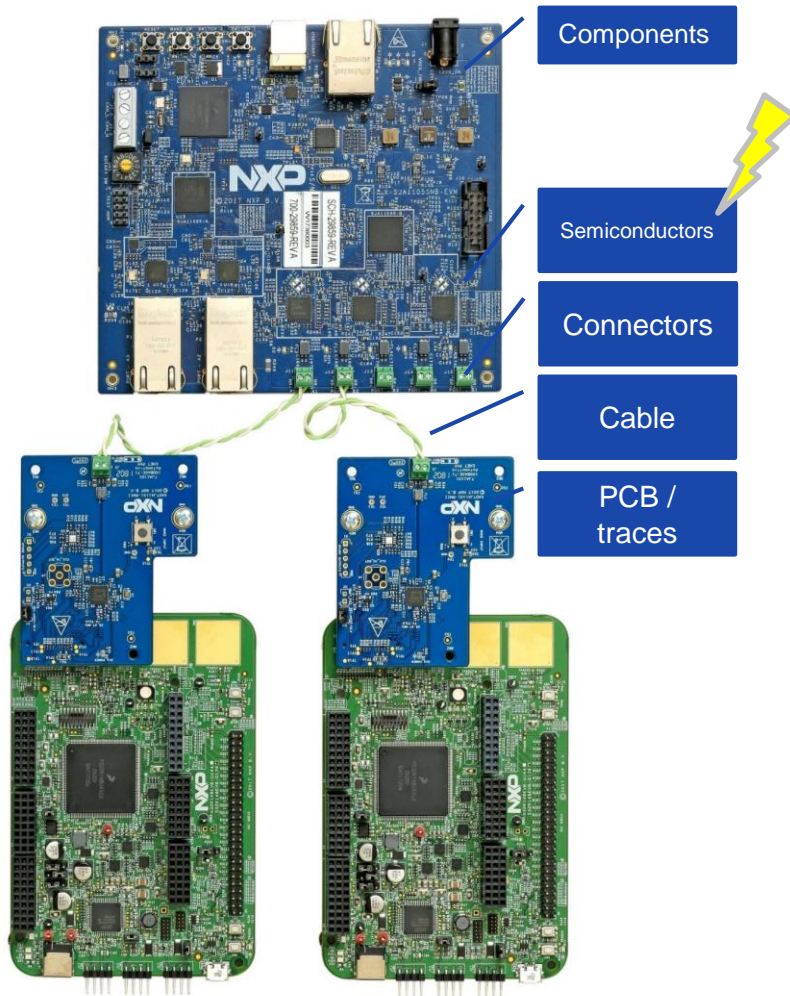
HOW THE NETWORKING IC KEEPS YOUR ROBO-CAR DRIVING?

Vehicle service availability can be improved by ensuring the availability of communication services in the vehicle. Networking chips can:

- Prevent Failure
 - Highest reliability
- Predict Failure
 - (Self-)Diagnostic features
- React to Failure
 - Quickest response time to increase FTTI margin
 - Even correct some failures



FAILURE PREVENTION - RELATION BETWEEN AVAILABILITY AND RELIABILITY



- Availability of communication is determined by the reliability of components in the signal path
- $\text{Total FIT} = \text{SUM (Component FIT)}$
- FIT (Failure In Time)
 - describes the probability that a component fails, i.e. random HW failure
 - Initially estimated based on technology parameters for future products (e.g. SN29500)
- Manufacturing quality directly impacts the FIT rate and probability of failure

MEASURE OF FAILURE PREVENTION
FROM FAILURE RATE TO SAFETY METRICS

Calculate
HW failure rate (FIT)



FMEDA											
Ref	Failure Mode	SE	Severity	SA	SC	SD	ST	SS	Failure Mode Description	SA	SC
	Logic error	10	10	10	10	10	10	10	Logic error (latching of output)	10	10
	24 pin data bus error	10	10	10	10	10	10	10	24 pin data bus error (latching of output)	10	10
	Internal error	10	10	10	10	10	10	10	Internal error (latching of output)	10	10
	Power supply	10	10	10	10	10	10	10	Power supply error (latching of output)	10	10
	IO	10	10	10	10	10	10	10	IO error (latching of output)	10	10
	Memory	10	10	10	10	10	10	10	Memory error (latching of output)	10	10

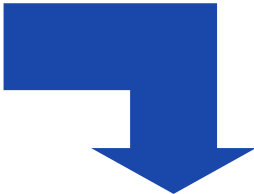
SafeAssure — FMEDA

FMEDA calculates the **Safety Metrics** required by ISO26262

- FMEDA: Failure Mode Effects and Diagnostic Analysis
- LFM: Latent Fault Metric
- PMHF: Probabilistic Metric for (Random) Hardware Failures
- SPFM: Single Point Fault Metric



SPFM
LFM
PMHF



Compare
with standard [ISO-26262, part 5]

ASIL	SPFM	LFM	PMHF
B	≥ 90 %	≥ 60 %	< 10 ⁻⁷ h ⁻¹
C	≥ 97 %	≥ 80 %	< 10 ⁻⁷ h ⁻¹
D	≥ 99 %	≥ 90 %	< 10 ⁻⁸ h ⁻¹

FAILURE PREVENTION

Example Reference FIT calculation

For Tjv / CL parameter details, please contact NXP

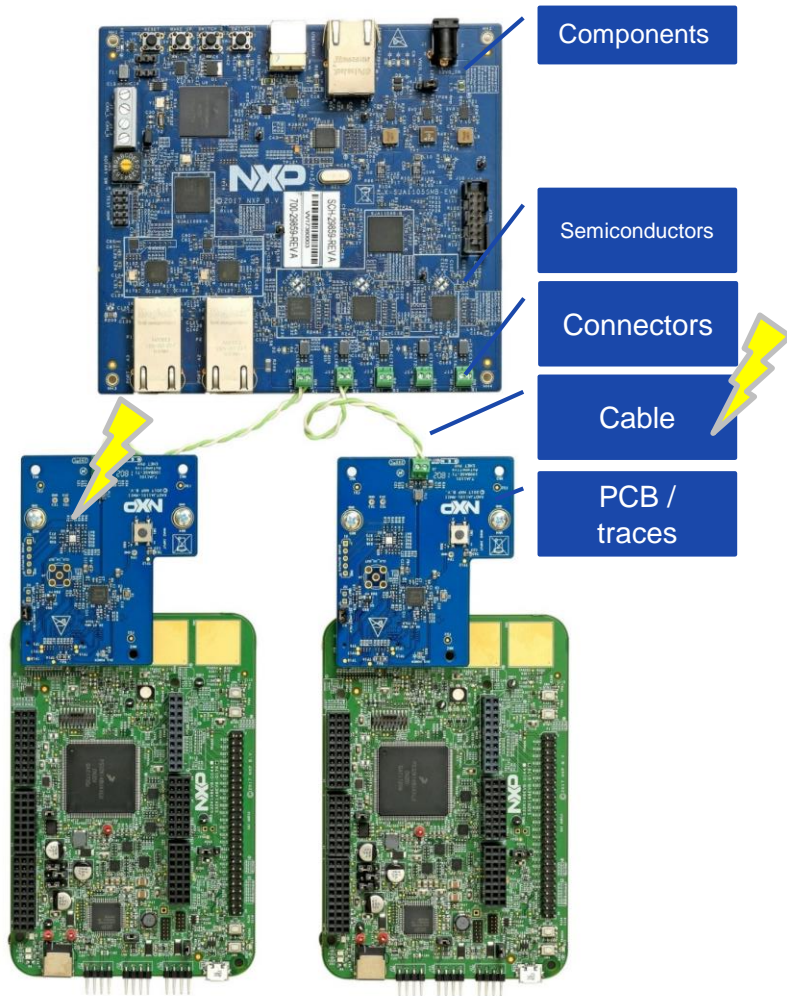
TJA1043U	Siemens Norm SN29500	HTOL Qual CAN Family	Production & Field Return Data CAN Family
Reference FIT calculation	42 FIT	3.0 FIT	0.04 FIT

Manufacturing quality makes the difference

- NXP applies screening & continuous improvement of screening methodology based on production and field return data
- The methodology is independent of process technology

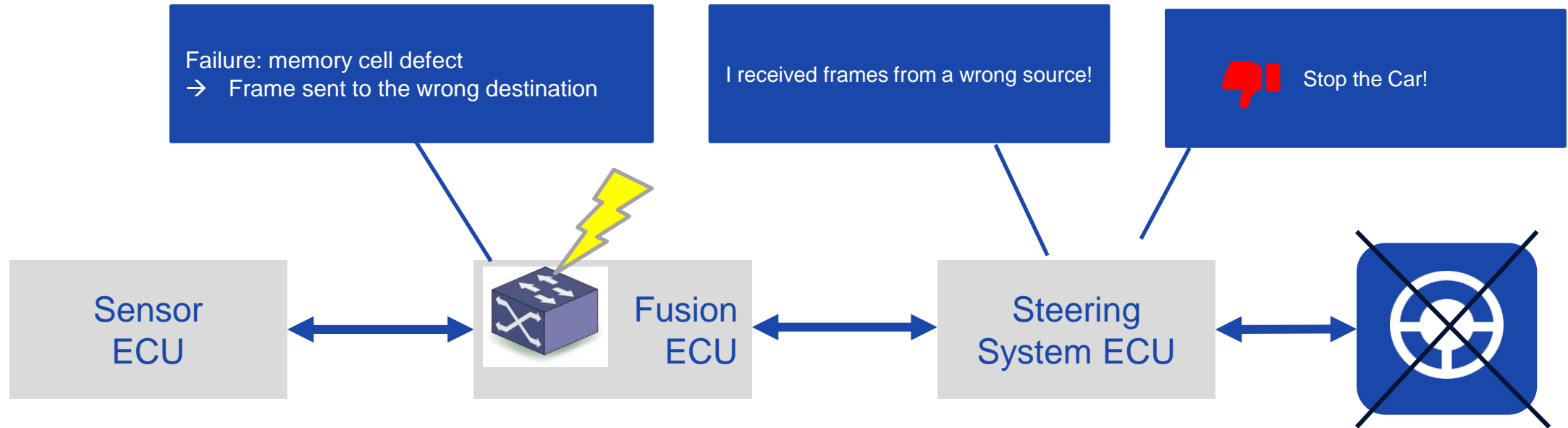
HTOL: High-Temperature Over Life

RELATION BETWEEN AVAILABILITY, PREDICTION AND REACTION



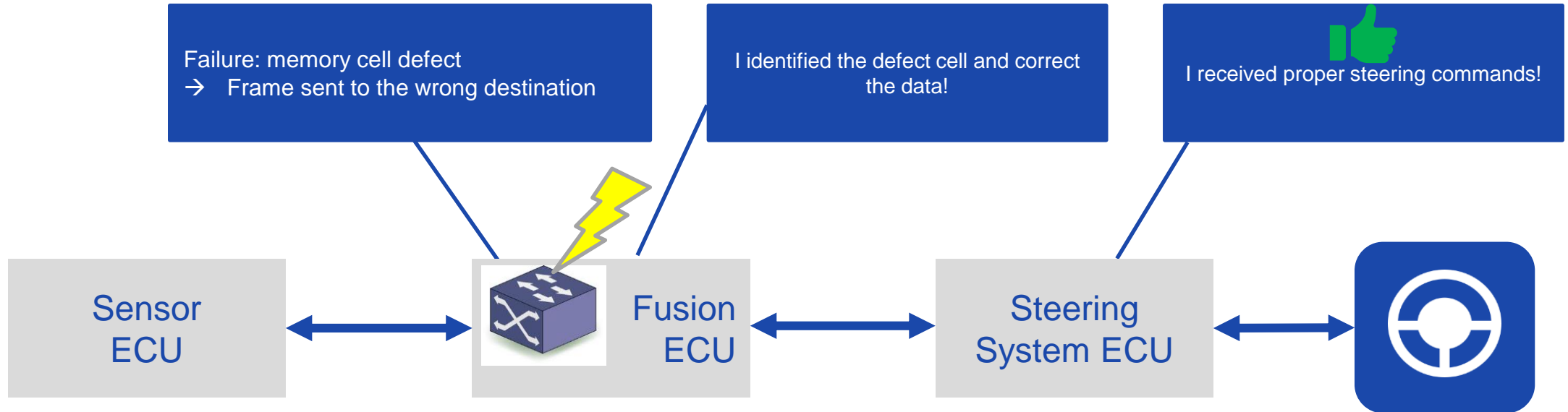
- Failure may occur anywhere in the communication chain, e.g. cable degradation or weak PCB solder connections
- Availability of communication is further determined by
 - The time it takes to detect (localize / categorize) issues
 - The ability to respond depending on the criticality of issues
- Examples of FuSa features on IC level
 - Predict:
 - Temperature / Voltage Monitoring
 - Signal Quality Indicator
 - React:
 - Memory Failure Correction (ECC)
 - IEEE 802.1CB (Stream replication / elimination)

FROM E2E PROTECTION TO HIGHLY AVAILABLE COMMUNICATION PATH EXAMPLE: ECC



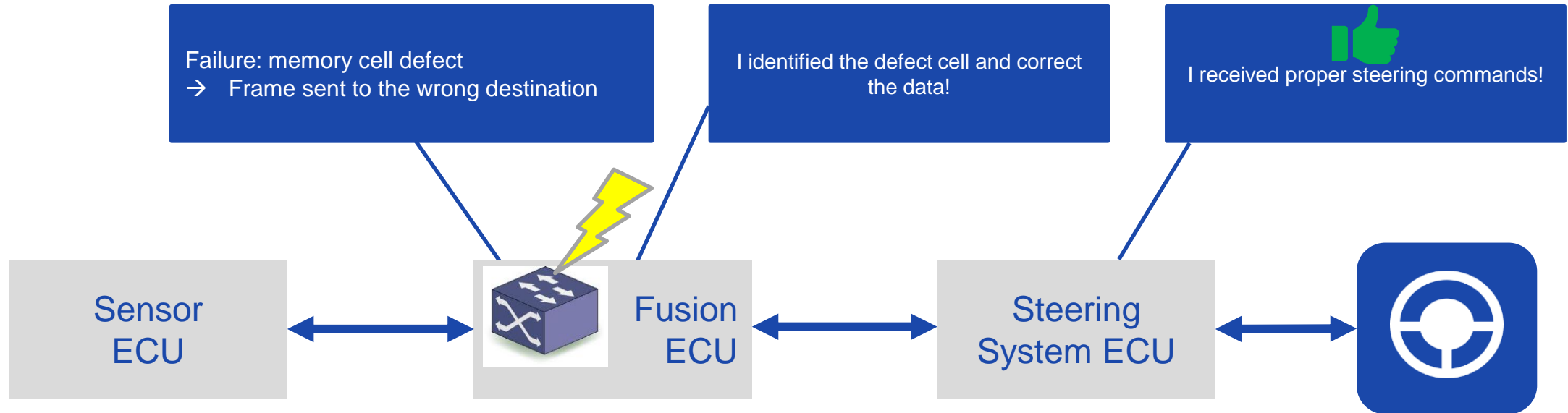
- Solution 1) Detected by end2end FuSa implementation!
→ system decision: trigger safe state → stop the car!

FROM E2E PROTECTION TO HIGHLY AVAILABLE COMMUNICATION PATH EXAMPLE: ECC



- Solutions 2) Handled by highly available system:
 - Local detection and correction
 - ECC: defective memory cell detected by the switch itself
 - Action triggered by the switch: report and / or repair!
 - System decision: → continue normal operation!
 - Request further data for evaluation
 - Trigger service stop & ECU exchange

FROM E2E PROTECTION TO HIGHLY AVAILABLE COMMUNICATION PATH EXAMPLE: ECC



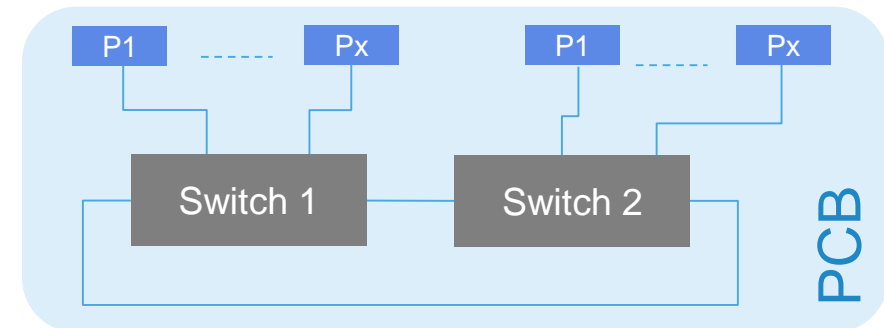
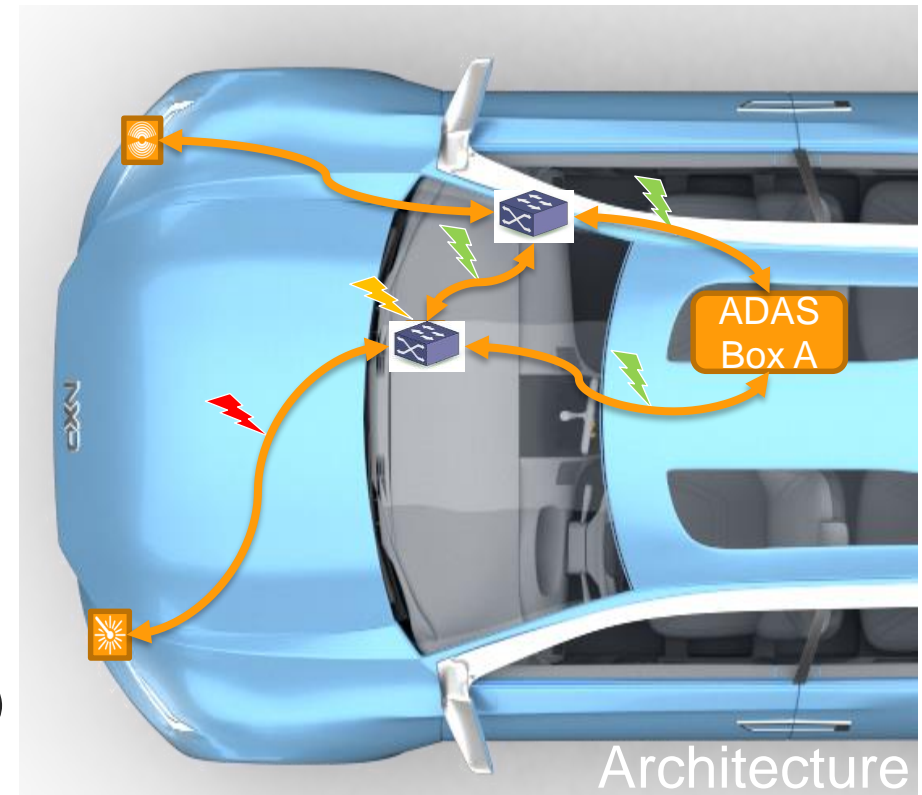
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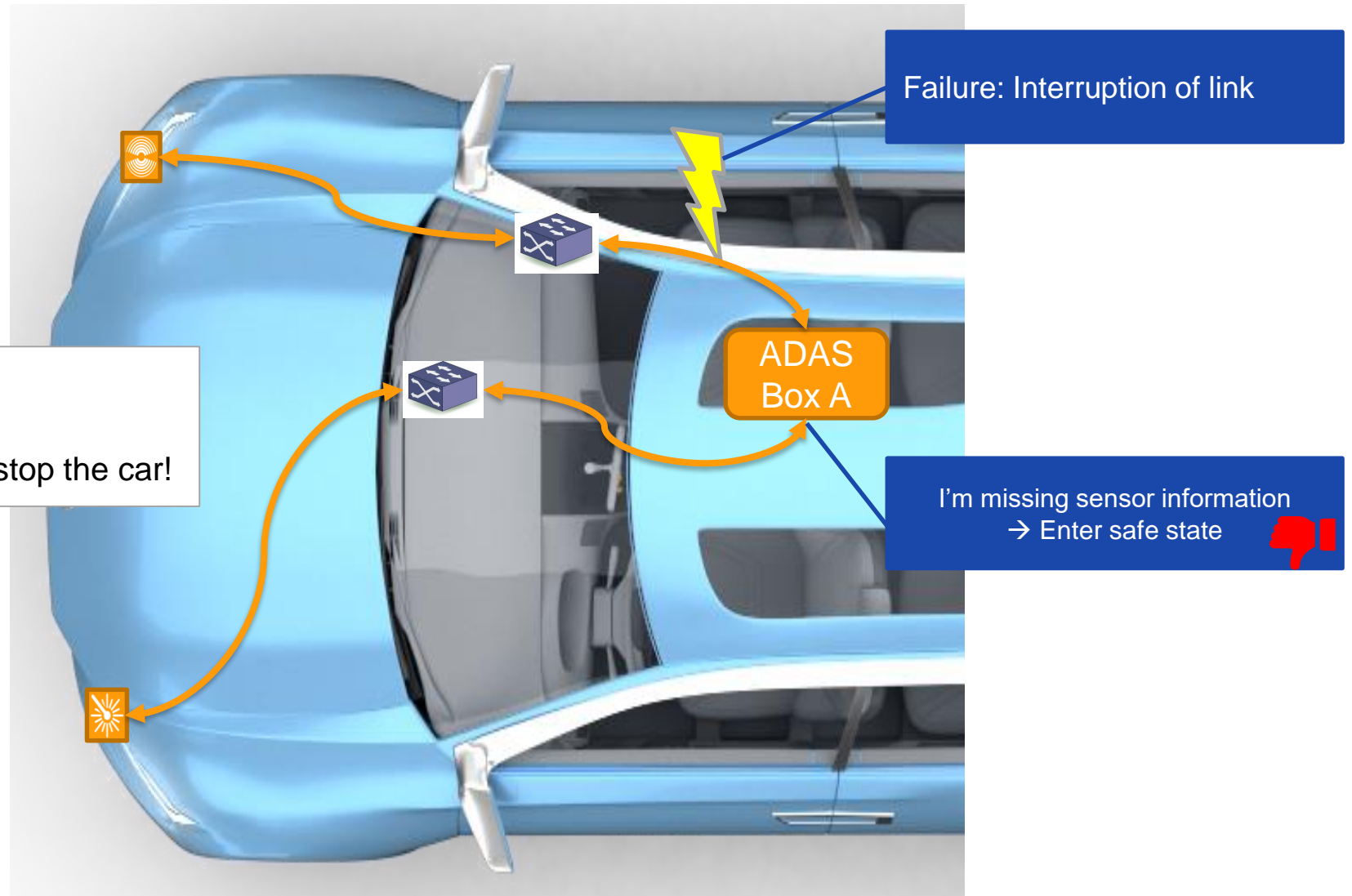
- Both system solutions achieve the same ASIL!
- Only the highly available system is enhanced by local detection / correction, plus the availability of information to the system level for more fine grain resolution of action
- In a redundant system, a part of the system may even be restarted during operation

ENABLE TO REACT: REPLICATION & ELIMINATION FEATURE (802.1CB)

- Create redundant data paths **within** the network
- Typically a part of network and data flow will be replicated
- **Increases the availability** of safety critical communication
 - Redundancy coverage determined by considered failures
 - e.g. cable failures, link interruption, switch failures, ...
 - Does not cover all failures, e.g. power supply loss.
- **Prevents** entering a safe state on transient faults (e.g. link down)
- Can be combined with full redundant system
- Integral part of network architecture
- Same concept on PCB level possible



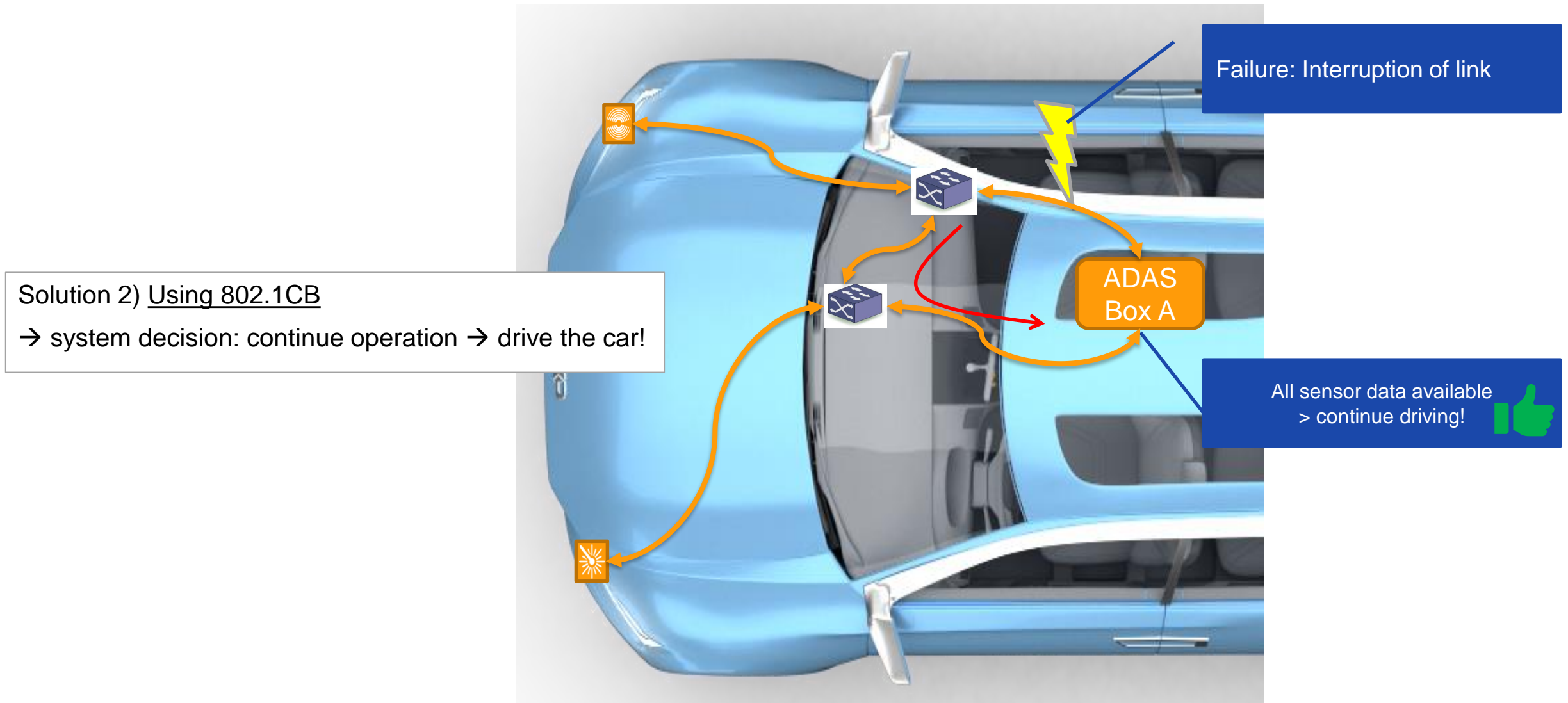
EXAMPLE: W/O REPLICATION & ELIMINATION FEATURE (802.1CB)



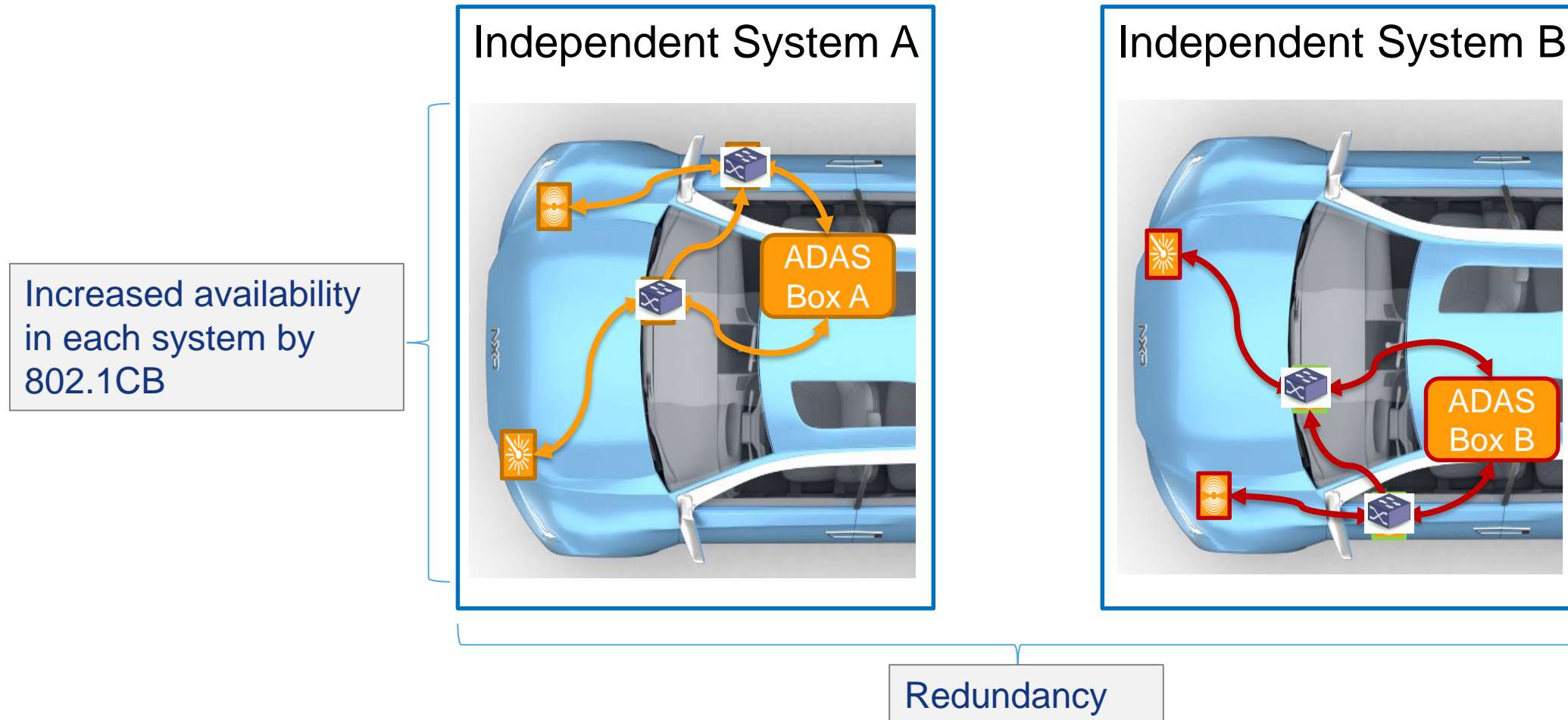
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→ system decision: trigger safe state → stop the car!

EXAMPLE: WITH REPLICATION & ELIMINATION FEATURE (802.1CB)



EXAMPLE: REPLICATION & ELIMINATION FEATURE (802.1CB)



CB for enhanced system availability, not for full system redundancy.

CONCLUSION

- Chip ASIL ratings are valid when the assumptions match the use case!
- Cars are safe today, future cars remain safe
- Vehicle availability (customer experience) can be enhanced
- Networking IC features can increase the vehicle availability by preventing, predicting and reacting to failure scenarios
- Manufacturing quality and development process are the basis for highly available systems
- NXP is a unique partner to co-define and realize safety & availability concepts for
 - Predictive Maintenance
 - Fail operational networks





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